







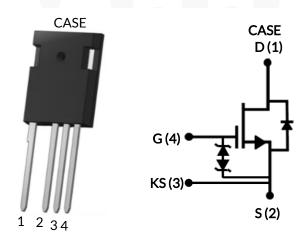








# UJ4C075033K4S



Part Number	Package	Marking
UJ4C075033K4S	TO-247-4L	UJ4C075033K4S







### 750V-33m $\Omega$ SiC FET

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#### Description

The UJ4C075033K4S is a 750V,  $33m\Omega$  G4 SiC FET. It is based on a unique 'cascode' circuit configuration, in which a normally-on SiC JFET is co-packaged with a Si MOSFET to produce a normally-off SiC FET device. The device's standard gate-drive characteristics allows for a true "drop-in replacement" to Si IGBTs, Si FETs, SiC MOSFETs or Si superjunction devices. Available in the TO-247-4L package, this device exhibits ultra-low gate charge and exceptional reverse recovery characteristics, making it ideal for switching inductive loads and any application requiring standard gate drive.

#### **Features**

- On-resistance  $R_{DS(on)}$ :  $33m\Omega$  (typ)
- Operating temperature: 175°C (max)
- ◆ Excellent reverse recovery: Q<sub>rr</sub> = 88nC
- Low body diode V<sub>FSD</sub>: 1.26V
- ◆ Low gate charge: Q<sub>G</sub> = 37.8nC
- Threshold voltage V<sub>G(th)</sub>: 4.8V (typ) allowing 0 to 15V drive
- Low intrinsic capacitance
- ESD protected: HBM class 2 and CDM class C3
- TO-247-4L package for faster switching, clean gate waveforms

#### Typical applications

- EV charging
- PV inverters
- Switch mode power supplies
- Power factor correction modules
- Motor drives
- Induction heating













# **Maximum Ratings**

Parameter	Symbol	Test Conditions	Value	Units
Drain-source voltage	V <sub>DS</sub>		750	V
C-t	\/	DC	-20 to +20	V
Gate-source voltage	$V_{GS}$	AC (f > 1Hz)	-25 to +25	V
Continuous drain current <sup>1</sup>	1	T <sub>C</sub> = 25°C	47	Α
Continuous drain current <sup>2</sup>	I <sub>D</sub>	T <sub>C</sub> =100°C	35	А
Pulsed drain current <sup>2</sup>	I <sub>DM</sub>	T <sub>C</sub> = 25°C	140	А
Single pulsed avalanche energy <sup>3</sup>	E <sub>AS</sub>	L=15mH, I <sub>AS</sub> =2.4A	43	mJ
SiC FET dv/dt ruggedness	dv/dt	$V_{DS} \le 500V$	200	V/ns
Power dissipation	P <sub>tot</sub>	T <sub>C</sub> = 25°C	242	W
Maximum junction temperature	$T_{J,max}$		175	°C
Operating and storage temperature	$T_J, T_{STG}$		-55 to 175	°C
Max. lead temperature for soldering, 1/8" from case for 5 seconds	T <sub>L</sub>		250	°C

- 1. Limited by  $T_{J,max}$
- 2. Pulse width  $t_p$  limited by  $T_{J,max}$
- 3. Starting  $T_J = 25^{\circ}C$

### **Thermal Characteristics**

Parameter	Symbol	Test Conditions	Value			Units
			Min	Тур	Max	Offics
Thermal resistance, junction-to-case	$R_{\theta JC}$			0.48	0.62	°C/W

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# Electrical Characteristics (T<sub>J</sub> = +25°C unless otherwise specified)

### **Typical Performance - Static**

Parameter	Symbol	Test Conditions		Units		
	Syllibol		Min	Тур	Max	Offics
Drain-source breakdown voltage	BV <sub>DS</sub>	$V_{GS}$ =0V, $I_D$ =1mA	750			V
		V <sub>DS</sub> =750V, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C		2	20	- μΑ
Total drain leakage current	I <sub>DSS</sub>	V <sub>DS</sub> =750V, V <sub>GS</sub> =0V, T <sub>J</sub> =175°C		20		
Total gate leakage current	I <sub>GSS</sub>	V <sub>DS</sub> =0V, T <sub>J</sub> =25°C, V <sub>GS</sub> =-20V / +20V		6	±20	μА
Drain-source on-resistance		$V_{GS}$ =12V, $I_{D}$ =30A, $T_{J}$ =25°C		33	41	
	R <sub>DS(on)</sub>	V <sub>GS</sub> =12V, I <sub>D</sub> =30A, T <sub>J</sub> =125°C		57		mΩ
		$V_{GS}$ =12V, $I_{D}$ =30A, $T_{J}$ =175°C		75		
Gate threshold voltage	$V_{G(th)}$	$V_{DS}$ =5V, $I_{D}$ =10mA	4	4.8	6	V
Gate resistance	$R_{G}$	f=1MHz, open drain		4.5		Ω

# Typical Performance - Reverse Diode

Parameter	Symbol	Test Conditions		Units		
			Min	Тур	Max	Units
Diode continuous forward current <sup>1</sup>	I <sub>S</sub>	T <sub>C</sub> = 25°C			47	Α
Diode pulse current <sup>2</sup>	I <sub>S,pulse</sub>	T <sub>C</sub> = 25°C			140	Α
Forward voltage	$V_{FSD}$	V <sub>GS</sub> =0V, I <sub>S</sub> =15A, T <sub>J</sub> =25°C		1.26	1.42	V
		V <sub>GS</sub> =0V, I <sub>S</sub> =15A, T <sub>J</sub> =175°C		1.59		
Reverse recovery charge	Q <sub>rr</sub>	$V_R$ =400V, $I_S$ =30A, $V_{GS}$ =0V, $R_{G\_EXT}$ =5 $\Omega$		88		nC
Reverse recovery time	t <sub>rr</sub>	di/dt=3100A/μs, T <sub>J</sub> =25°C		11.5		ns
Reverse recovery charge	Q <sub>rr</sub>	$V_R$ =400V, $I_S$ =30A, $V_{GS}$ =0V, $R_{G\_EXT}$ =5 $\Omega$		95		nC
Reverse recovery time	t <sub>rr</sub>	di/dt=3100A/μs, Τ <sub>J</sub> =150°C		12		ns

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Parameter	Symbol Test Conditions	Value			Unite	
	Symbol	Test Conditions -	Min	Тур	Max	Units
Input capacitance	$C_{iss}$	V <sub>DS</sub> =400V, V <sub>GS</sub> =0V		1400		
Output capacitance	$C_{oss}$	f=100kHz		68		pF
Reverse transfer capacitance	$C_{rss}$			2.5		
Effective output capacitance, energy related	$C_{oss(er)}$	V <sub>DS</sub> =0V to 400V, V <sub>GS</sub> =0V		83		pF
Effective output capacitance, time related	C <sub>oss(tr)</sub>	$V_{DS}$ =0V to 400V, $V_{GS}$ =0V		162		pF
C <sub>OSS</sub> stored energy	E <sub>oss</sub>	V <sub>DS</sub> =400V, V <sub>GS</sub> =0V		6.6		μЈ
Total gate charge	$Q_{G}$	V <sub>DS</sub> =400V, I <sub>D</sub> =30A,		37.8		
Gate-drain charge	$Q_{GD}$	$V_{GS} = 0V \text{ to } 15V$		8		nC
Gate-source charge	$Q_{GS}$	VGS 0 V to 13 V		11.8		
Turn-on delay time	$t_{d(on)}$	Notes 4 and 5,		12		- ns
Rise time	$t_r$	V <sub>DS</sub> =400V, I <sub>D</sub> =30A, Gate		19		
Turn-off delay time	t <sub>d(off)</sub>	Driver =0V to +15V, Turn-on $R_{G,EXT}$ =1 $\Omega$ , Turn-off $R_{G,EXT}$ =5 $\Omega$ ,		18		
Fall time	t <sub>f</sub>			7		
Turn-on energy including R <sub>S</sub> energy	E <sub>ON</sub>	inductive Load,		131		μJ
Turn-off energy including R <sub>S</sub> energy	E <sub>OFF</sub>	FWD: same device with $V_{GS} = 0V$ and $R_G = 5\Omega$ ,		24		
Total switching energy	E <sub>TOTAL</sub>	RC snubber: $R_s$ =15 $\Omega$ and		155		
Snubber R <sub>S</sub> energy during turn-on	E <sub>RS_ON</sub>	C <sub>S</sub> =100pF,		3.2		
Snubber R <sub>S</sub> energy during turn-off	E <sub>RS_OFF</sub>	T <sub>J</sub> =25°C		10		
Turn-on delay time	$t_{d(on)}$	Notes 4 and 5,		13		
Rise time	$t_r$	$V_{DS}$ =400V, $I_D$ =30A, Gate		21		
Turn-off delay time	t <sub>d(off)</sub>	Driver =0V to +15V,		20		- ns
Fall time	t <sub>f</sub>	Turn-on $R_{G,EXT} = 1\Omega$ , Turn-off $R_{G,EXT} = 5\Omega$ , inductive Load, FWD: same device with $V_{GS} = 0V$ and $R_{G} = 5\Omega$ , RC snubber: $R_{S} = 15\Omega$ and		9		
Turn-on energy including R <sub>S</sub> energy	E <sub>ON</sub>			160		
Turn-off energy including R <sub>S</sub> energy	E <sub>OFF</sub>			41		
Total switching energy	E <sub>TOTAL</sub>			201		μЈ
Snubber R <sub>S</sub> energy during turn-on	E <sub>RS_ON</sub>	C <sub>S</sub> =100pF,		3		
Snubber R <sub>S</sub> energy during turn-off	E <sub>RS_OFF</sub>	T <sub>J</sub> =150°C		9.6		

<sup>4.</sup> Measured with the switching test circuit in Figure 35.

<sup>5.</sup> In this datasheet, all the switching energies (turn-on energy, turn-off energy and total energy) presented in the tables and Figures include the device RC snubber energy losses.















Parameter	Symbol	Test Conditions	Value			Units
		rest Conditions	Min	Тур	Max	Offics
Turn-on delay time	t <sub>d(on)</sub>			11.5		
Rise time	t <sub>r</sub>	Note 6, V <sub>DS</sub> =400V, I <sub>D</sub> =30A, Gate		19		ns
Turn-off delay time	$t_{d(off)}$	Driver =0V to +15V,		17.5		115
Fall time	t <sub>f</sub>	Turn-on $R_{G,EXT}=1\Omega$ ,		6		
Turn-on energy including R <sub>S</sub> energy	E <sub>ON</sub>	Turn-off $R_{G,EXT} = 5\Omega$ , inductive Load.		114		
Turn-off energy including R <sub>S</sub> energy	E <sub>OFF</sub>	FWD: UJ3D06520TS,		22		
Total switching energy	E <sub>TOTAL</sub>	RC snubber: $R_s=15\Omega$ and $C_s=100pF$ ,		136		μЈ
Snubber R <sub>S</sub> energy during turn-on	E <sub>RS_ON</sub>	С <sub>S</sub> =100рг, Т <sub>J</sub> =25°С		4.1		
Snubber R <sub>S</sub> energy during turn-off	E <sub>RS_OFF</sub>			14		
Turn-on delay time	t <sub>d(on)</sub>			13		
Rise time	t <sub>r</sub>	Note 6, V <sub>DS</sub> =400V, I <sub>D</sub> =30A, Gate		16		ns
Turn-off delay time	t <sub>d(off)</sub>	Driver =0V to +15V,		23		115
Fall time	t <sub>f</sub>	Turn-on $R_{G,EXT}=1\Omega$ , Turn-		7		
Turn-on energy including $R_{\text{S}}$ energy	E <sub>oN</sub>	$\begin{array}{c} \text{ off } R_{G,EXT} \! \! = \! 5\Omega, \\ \text{ inductive Load,} \\ \text{ FWD: UJ3D06520TS,} \\ \text{ RC snubber: } R_S \! \! = \! 15\Omega \text{ and} \\ \\ C_S \! \! = \! 100 \text{pF,} \\ \\ T_J \! \! = \! 150^{\circ}\text{C} \end{array}$		137		
Turn-off energy including $R_S$ energy	E <sub>OFF</sub>			39		
Total switching energy	E <sub>TOTAL</sub>			176		μЈ
Snubber R <sub>S</sub> energy during turn-on	E <sub>RS_ON</sub>			4		
Snubber R <sub>S</sub> energy during turn-off	E <sub>RS_OFF</sub>			14		

<sup>6.</sup> Measured with the switching test circuit in Figure 36.

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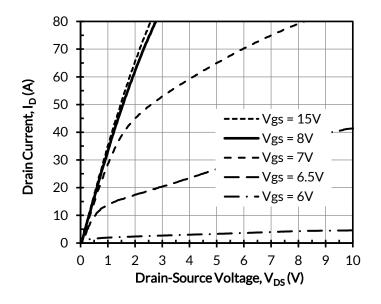








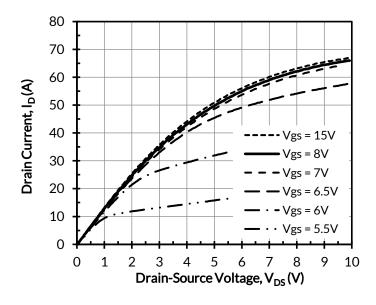
### **Typical Performance Diagrams**



80 70 60 Drain Current, I<sub>D</sub> (A) 50 40 Vgs = 15V30 Vgs = 8V Vgs = 7V20 - Vgs = 6.5V 10 Vgs = 6V 0 0 1 2 3 5 10 Drain-Source Voltage, V<sub>DS</sub> (V)

Figure 1. Typical output characteristics at  $T_J$  = - 55°C, tp < 250 $\mu$ s

Figure 2. Typical output characteristics at  $T_J = 25$ °C, tp <  $250\mu$ s



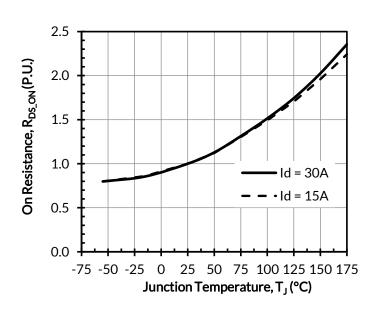


Figure 3. Typical output characteristics at  $T_J$  = 175°C, tp < 250 $\mu$ s

Figure 4. Normalized on-resistance vs. temperature at  $V_{GS}$  = 12V



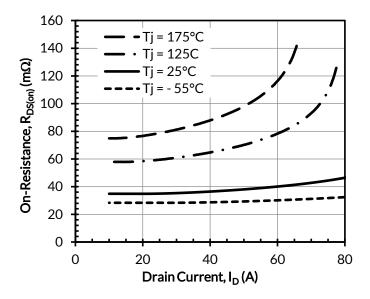








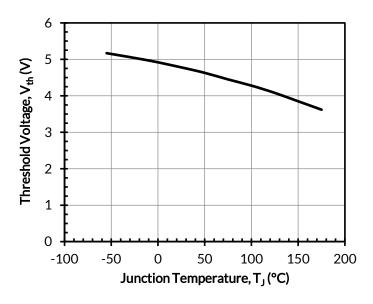




Tj = -55°C Tj = 25°C Drain Current, I<sub>D</sub> (A) Tj = 175°C Gate-Source Voltage,  $V_{GS}(V)$ 

Figure 5. Typical drain-source on-resistances at  $V_{\text{GS}}$  = 12V

Figure 6. Typical transfer characteristics at  $V_{DS}$  = 5V



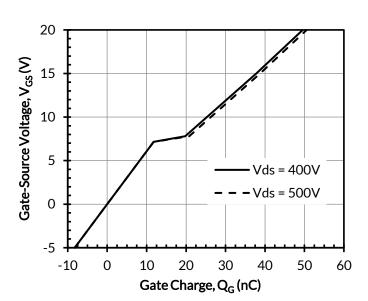


Figure 7. Threshold voltage vs. junction temperature at  $V_{DS}$  = 5V and  $I_{D}$  = 10mA

Figure 8. Typical gate charge at  $I_D$  = 30A















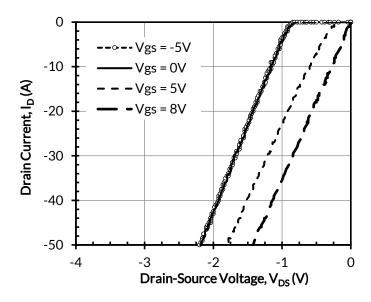


Figure 9. 3rd quadrant characteristics at  $T_J = -55$ °C

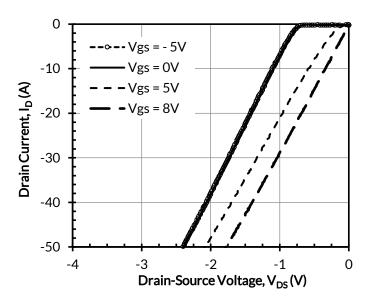


Figure 10. 3rd quadrant characteristics at  $T_J = 25$ °C

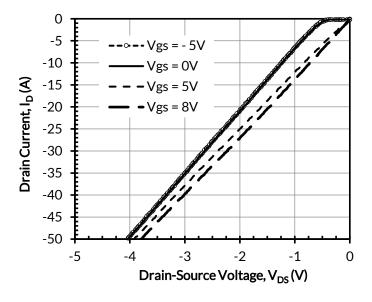


Figure 11. 3rd quadrant characteristics at  $T_J = 175$ °C

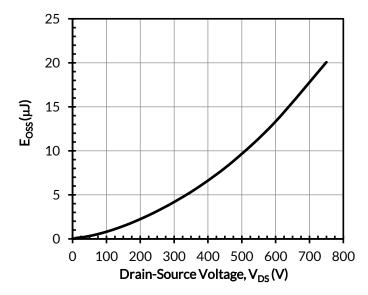


Figure 12. Typical stored energy in  $C_{OSS}$  at  $V_{GS} = 0V$ 



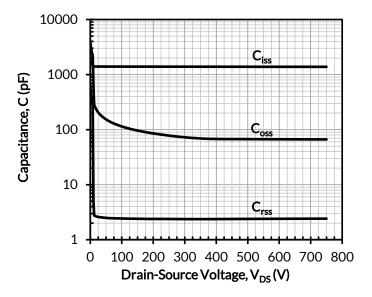












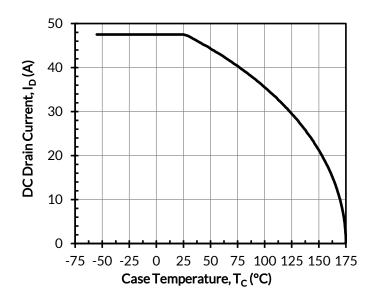
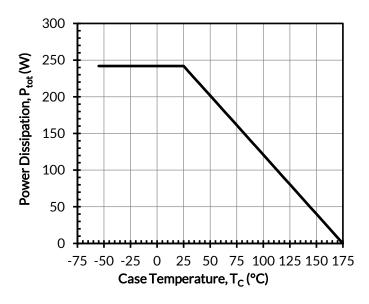


Figure 13. Typical capacitances at f = 100kHz and  $V_{GS} = 0V$ 

Figure 14. DC drain current derating



1 Thermal Impedance,  $Z_{\theta JC}$  (°C/W) 0.1 D = 0.5D = 0.3**-** D = 0.1 0.01 - D = 0.05 ···· D = 0.02 -D = 0.01Single Pulse 0.001 1.E-06 1.E-05 1.E-04 1.E-03 1.E-02 1.E-01 Pulse Time, t<sub>p</sub> (s)

Figure 15. Total power dissipation

Figure 16. Maximum transient thermal impedance













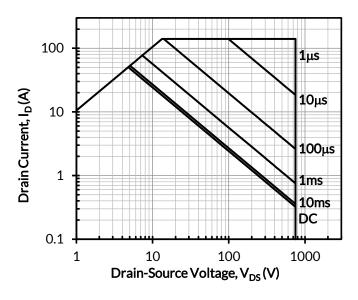


Figure 17. Safe operation area at  $T_C$  = 25°C, D = 0, Parameter  $t_p$ 

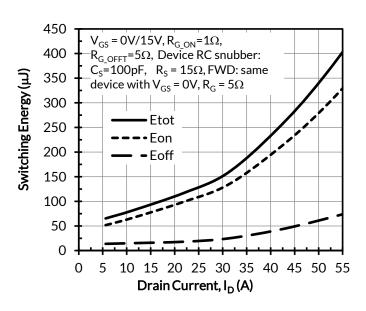


Figure 19. Clamped inductive switching energy vs. drain current at  $V_{DS}$  = 400V and  $T_J$  = 25°C

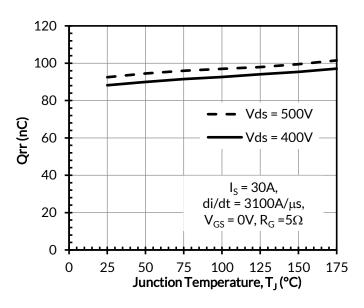


Figure 18. Reverse recovery charge Qrr vs. junction temperature

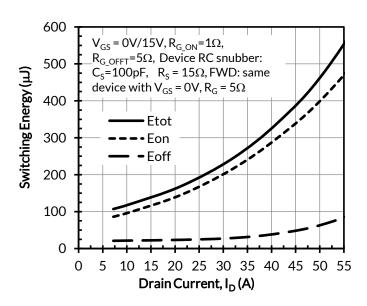


Figure 20. Clamped inductive switching energy vs. drain current at  $V_{DS} = 500V$  and  $T_J = 25^{\circ}C$ 





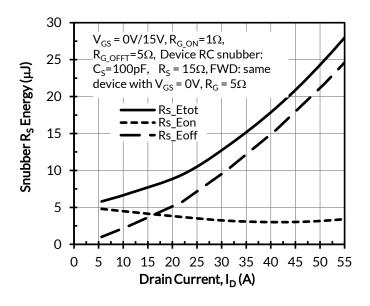








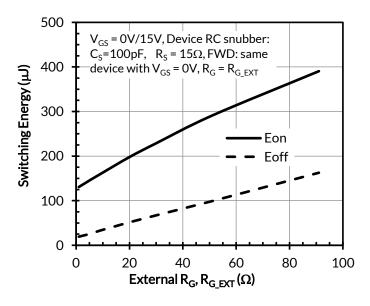




30  $V_{GS} = 0V/15V, R_{G\_ON} = 1\Omega, R_{G\_OFFT} = 5\Omega,$ Device RC snubber:  $C_S = 100 \text{pF}$ ,  $R_S = 15 \Omega$ , 25 FWD: same device with  $V_{GS} = 0V$ ,  $R_G = 5\Omega$ Snubber R<sub>S</sub> Energy (µJ) Rs\_Etot 20 • • Rs\_Eon - Rs\_Eoff 15 10 5 0 0 5 10 15 20 25 30 35 40 45 50 55 Drain Current, ID (A)

Figure 21. RC snubber energy loss vs. drain current at  $V_{DS} = 400V$  and  $T_J = 25$ °C

Figure 22. RC snubber energy losses vs. drain current at  $V_{DS}$  = 500V and  $T_J$  = 25°C



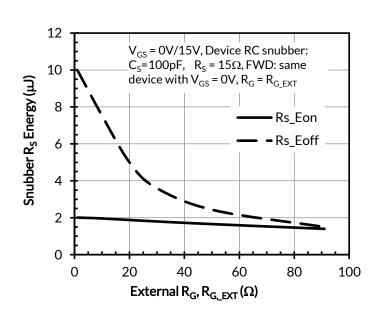


Figure 23. Clamped inductive switching energies vs.  $R_{G.EXT}$  at  $V_{DS}$  = 400V,  $I_{D}$  = 30A, and  $T_{J}$  = 25°C

Figure 24. RC snubber energy losses vs.  $R_{G.EXT}$  at  $V_{DS}$  = 400V,  $I_D = 30A$ , and  $T_I = 25$ °C





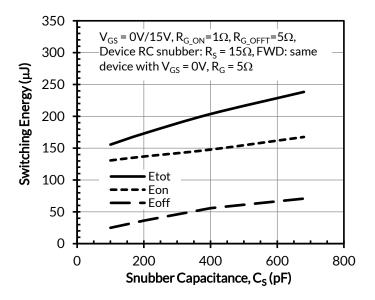








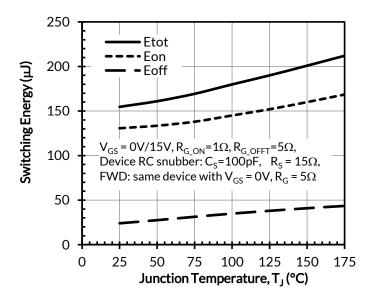




80  $V_{GS} = 0V/15V, R_{G_{-}ON} = 1\Omega,$ 70  $R_{G OFFT} = 5\Omega$ , Device RC snubber:  $R_S = 15\Omega$ , FWD: Snubber R<sub>s</sub> Energy (μJ) 60 same device with  $V_{GS} = 0V$ ,  $R_G = 5\Omega$ 50 40 30 20 Rs\_Etot 10 Rs Eon Rs\_Eoff 0 0 200 400 600 800 Snubber Capacitance, C<sub>S</sub> (pF)

Figure 25. Clamped inductive switching energies vs. snubber capacitance  $C_S$  at  $V_{DS}$  = 400V,  $I_D$  = 30A, and  $T_1$  = 25°C

Figure 26. RC snubber energy losses vs. snubber capacitance  $C_S$  at  $V_{DS}$  = 400V,  $I_D$  = 30A, and  $T_J$  = 25°C



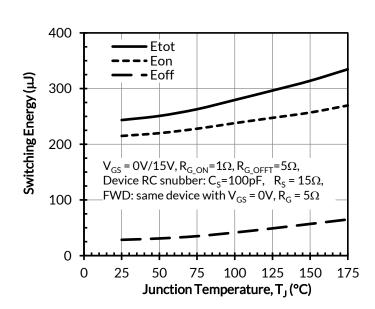


Figure 27. Clamped inductive switching energy vs. junction temperature at  $V_{DS}$  =400V and  $I_{D}$  = 30A

Figure 28. Clamped inductive switching energy vs. junction temperature at  $V_{DS}$  = 500V and  $I_D$  = 30A













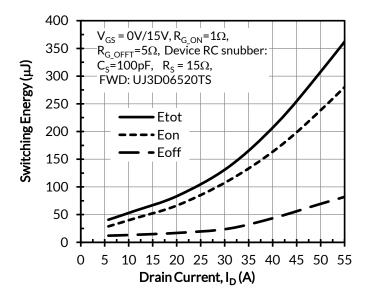


Figure 29. Clamped inductive switching energy vs. drain current at  $V_{DS} = 400V$  and  $T_J = 25^{\circ}C$ 

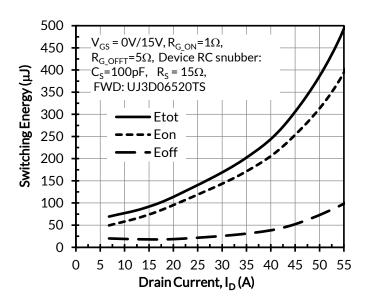


Figure 30. Clamped inductive switching energy vs. drain current at  $V_{DS}$  = 500V and  $T_J$  = 25°C

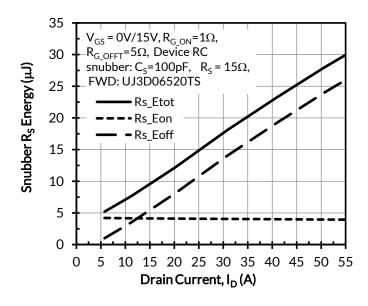


Figure 31. RC snubber energy losses vs. drain current at  $V_{DS}$  = 400V and  $T_J$  = 25°C

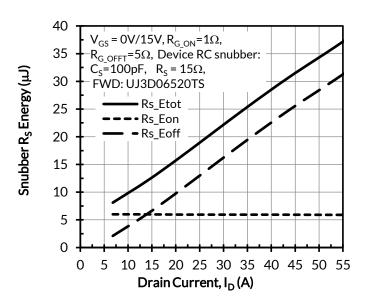


Figure 32. RC snubber energy losses vs. drain current at  $V_{DS} = 500V$  and  $T_J = 25^{\circ}C$ 





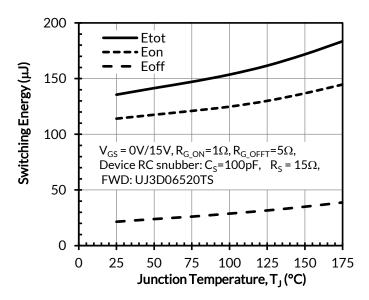








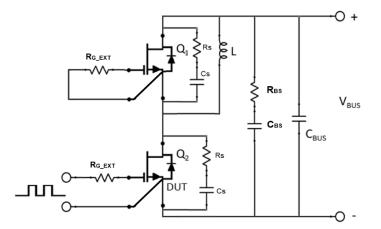




350 Etot 300 **Eoff** Switching Energy (μJ) 250 200 150 
$$\begin{split} V_{GS} = 0 V/15 V, R_{G\_ON} = 1 \Omega, R_{G\_OFFT} = 5 \Omega, \\ \text{Device RC snubber: } C_S = 100 \text{pF}, \quad R_S = 15 \Omega, \end{split}$$
100 FWD: UJ3D06520TS 50 0 0 25 75 100 125 150 Junction Temperature, T<sub>1</sub> (°C)

Figure 33. Clamped inductive switching energy vs. junction temperature at  $V_{DS}$  =400V and  $I_D$  = 30A

Figure 34. Clamped inductive switching energy vs. junction temperature at  $V_{DS}$  = 500V and  $I_D$  = 30A



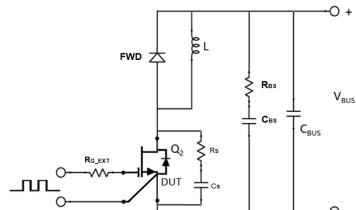


Figure 35. Schematic of the half-bridge mode switching test circuit. Note, a bus RC snubber ( $R_{BS}$  =  $2.5\Omega$ ,  $C_{BS}$ =100nF) is used to reduce the power loop high frequency oscillations.

Figure 36. Schematic of the chopper mode switching test circuit. Note, a bus RC snubber ( $R_{BS}$  = 2.5 $\Omega$ , C<sub>BS</sub>=100nF) is used to reduce the power loop high frequency oscillations.













#### **Applications Information**

SiC FETs are enhancement-mode power switches formed by a high-voltage SiC depletion-mode JFET and a low-voltage silicon MOSFET connected in series. The silicon MOSFET serves as the control unit while the SiC JFET provides high voltage blocking in the off state. This combination of devices in a single package provides compatibility with standard gate drivers and offers superior performance in terms of low on-resistance ( $R_{DS(on)}$ ), output capacitance ( $C_{oss}$ ), gate charge ( $Q_G$ ), and reverse recovery charge ( $Q_{rr}$ ) leading to low conduction and switching losses. The SiC FETs also provide excellent reverse conduction capability eliminating the need for an external anti-parallel diode.

Like other high performance power switches, proper PCB layout design to minimize circuit parasitics is strongly recommended due to the high dv/dt and di/dt rates. An external gate resistor is recommended when the FET is working in the diode mode in order to achieve the optimum reverse recovery performance. For more information on SiC FET operation, see www.unitedsic.com.

A snubber circuit with a small  $R_{(G)}$ , or gate resistor, provides better EMI suppression with higher efficiency compared to using a high  $R_{(G)}$  value. There is no extra gate delay time when using the snubber circuitry, and a small  $R_{(G)}$  will better control both the turn-off  $V_{(DS)}$  peak spike and ringing duration, while a high  $R_{(G)}$  will damp the peak spike but result in a longer delay time. In addition, the total switching loss when using a snubber circuit is less than using high  $R_{(G)}$ , while greatly reducing  $E_{(OFF)}$  from mid-to-full load range with only a small increase in  $E_{(ON)}$ . Efficiency will therefore improve with higher load current. For more information on how a snubber circuit will improve overall system performance, visit the UnitedSiC website at www.unitedsic.com

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